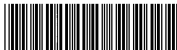


Search Notes**Application/Control No.**

10/663,774

Examiner

Dung Nguyen

**Applicant(s)/Patent under
Reexamination**

LEE ET AL.

Art Unit

2871

SEARCHED

Class	Subclass	Date	Examiner
349	updated search	2/3/2008	DN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated east	2/3/2008	DN